SCBS041D - NOVEMBER 1989 - REVISED NOVEMBER 1993

- BiCMOS Design Significantly Reduces ICCZ
- ESD Protection Exceeds 2000 V Per MIL-STD-883C, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Open-Collector Outputs Drive Bus Lines or Buffer Memory Address Registers
- Package Options Include Plastic Small-Outline (DW) Packages and Standard Plastic 300-mil DIPs (N)

description

This octal buffer and line driver is designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. This device provides complementary output-enable (OE and \overline{OE}) inputs and noninverting outputs.

The SN74BCT757 is characterized for operation from 0°C to 70°C.

DW OR N PACKAGE (TOP VIEW)

1 <mark>OE</mark>	d	1	U	20	Vcc
1A1	D	2		19	V _{CC} 20E
2Y4		3		18] 1Y1
1A2	_	4		17] 2A4
2Y3		5		16] 1Y2
1A3		6		15] 2A3
2Y2		7		14] 1Y3
1A4		8		13	2A2
2Y1		9		12] 1Y4
GND	4	10		11	2A1

FUNCTION TABLES

INP	JTS	OUTPUT
10E	1A	1Y
Н	Χ	Н
L	L	L L
L	Н	Н

		NUMBER OF STREET
INP	JTS	OUTPUT
20E	2A	2Y
L	Χ	Н
Н	L	L
Н	Н	н

logic symbol†

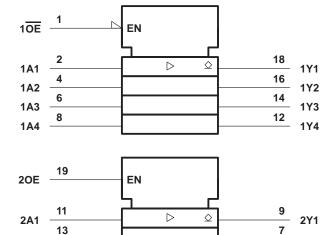
2A2

2A3

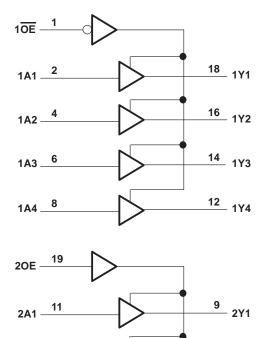
2A4

15

17



logic diagram (positive logic)



2A2 13 7 2Y2 2A3 15 5 2Y3 2A4 17 3 2Y4

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

2Y2

2Y3

2Y4

5

3

Supply voltage range, V _{CC}	-0.5 V to 7 V
Input voltage range, V ₁	-0.5 V to 7 V
Input current range, I ₁	0 mA to 5 mA
Voltage range applied to any output in the disabled or power-off state, V _O –C	0.5 V to 5.5 V
Voltage range applied to any output in the high state, V _O –	0.5 V to V _{CC}
Current into any output in the low state, I _O	128 mA
Operating free-air temperature range	0°C to 70°C
Storage temperature range –68	5°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

recommended operating conditions (see Note 1)

		MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	V
VIH	High-level input voltage	2			V
V_{IL}	Low-level input voltage			0.8	V
Vон	High-level output voltage			5.5	V
ΙΙΚ	Input clamp current			-18	mA
loL	Low-level output current			64	mA
TA	Operating free-air temperature	0		70	°C

NOTE 1: Unused or floating inputs must be held high or low.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITION	IS	MIN	TYP [†]	MAX	UNIT
VIK	$V_{CC} = 4.5 \text{ V},$	$I_{I} = -18 \text{ mA}$				-1.2	V
V _{OL}	$V_{CC} = 4.5 \text{ V},$	$I_{OL} = 64 \text{ mA}$			0.42	0.55	V
lį	$V_{CC} = 5.5 \text{ V},$	V _I = 7 V				0.1	mA
lіН	$V_{CC} = 5.5 \text{ V},$	V _I = 2.7 V				20	μΑ
IĮL	$V_{CC} = 5.5 \text{ V},$	V _I = 0.5 V	V _I = 0.5 V			-1	mA
IOH	$V_{CC} = 4.5 \text{ V},$	V _{OH} = 5.5 V				0.1	mA
			Outputs high			34	
ICC	$V_{CC} = 5.5 V$,	Outputs open	Outputs low			77	mA
			OE and OE inactive			10	
Ci	$V_{CC} = 5 V$,	$V_{I} = 2.5 \text{ V or } 0.5 \text{ V}$			6		pF
Co	V _{CC} = 5 V,	$V_0 = 2.5 \text{ V or } 0.5 \text{ V}$			4		pF

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

switching characteristics over recommended ranges of supply voltage and operating free-air temperature, C_L = 50 pF (unless otherwise noted) (see Note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$I \qquad I \Delta = 25$ °C		MIN MAX	UNIT		
	(INFOT)	(001701)	MIN	TYP	MAX			
^t PLH	А	Υ -	6.9	8.3	9.6	6.6	10.1	ns
^t PHL			2.4	4.2	6	2	6.6	
^t PLH	20E	V	11	14.8	17.9	10.8	19.7	ns
^t PHL		ı	2.9	4.6	6.2	2.6	6.9	115
t _{PLH}	1 0E	V	11.4	13.9	16.1	10	18	ns
^t PHL	IOL	1	4.4	6.1	7.8	4	8.5	115

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



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